

| L Number | Hits | Search Text | DB | Time stamp |
|----------|--------|--|-------|------------------|
| - | 480 | 156/345.33 156/345.34 156/345.29 156/345.38 156/345.26 | USPAT | 2003/09/05 12:49 |
| - | 978 | 134/113 156/345.18 156/345.21 | USPAT | 2003/09/05 12:49 |
| - | 2 | "edge bead" and (134/113 156/345.18 156/345.21) | USPAT | 2004/02/20 14:48 |
| - | 482 | 156/345.33 156/345.34 156/345.29 156/345.38 156/345.26 | USPAT | 2003/09/05 12:49 |
| - | 980 | 134/113 156/345.18 156/345.21 | USPAT | 2003/09/05 12:58 |
| - | 1461 | (156/345.33 156/345.34 156/345.29 156/345.38 156/345.26) (134/113 156/345.18 156/345.21) | USPAT | 2003/09/05 12:58 |
| - | 191 | ((156/345.33 156/345.34 156/345.29 156/345.38 156/345.26) (134/113 156/345.18 156/345.21)) and suc\$4 | USPAT | 2003/09/05 12:58 |
| - | 163431 | resist or (((dry plasma) with etch\$3) and (mask)) | USPAT | 2003/09/05 12:59 |
| - | 27 | ((156/345.33 156/345.34 156/345.29 156/345.38 156/345.26) (134/113 156/345.18 156/345.21)) and suc\$4) and ((resist or (((dry plasma) with etch\$3) and (mask))) and ((156/345.33 156/345.34 156/345.29 156/345.38 156/345.26) (134/113 156/345.18 156/345.21))) | USPAT | 2003/09/05 12:59 |
| - | 214 | (resist or (((dry plasma) with etch\$3) and (mask))) and ((156/345.33 156/345.34 156/345.29 156/345.38 156/345.26) (134/113 156/345.18 156/345.21)) | USPAT | 2003/09/05 13:10 |
| - | 1516 | "edge bead" | USPAT | 2004/02/20 14:48 |
| - | 408 | "edge bead" and (wafer substrate semiconductor) | USPAT | 2004/02/20 14:49 |